

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/653,222	LI, JIN	
Examiner		Art Unit	Page 1 of 1	
Edgardo Ortiz		2815		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,104,021	08-2000	Ogawa, Chihiro	250/208.1
	B	US-5,701,008	12-1997	Ray et al.	250/352
	C	US-6,188,094	02-2001	Kochi et al.	257/232
	D	US-6,803,250	10-2004	Yaung et al.	438/70
	E	US-5,298,366	03-1994	Iwasaki et al.	430/321
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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